

10/582665

AP3 Rec'd PCT/PTO 13 JUN 2005

PATENT

Docket No.: NIP-002

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

Toshihisa WATANAE et al.

U.S. Patent Application No.: -----

Filed: *herewith*

:
:
:
:
:
:

Confirmation No.

Group Art Unit: -----

For: **X-RAY DETECTION DEVICE FOR FOREIGN MATTER**

PRELIMINARY AMENDMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Dear Sir:

Preliminary to examination of the above-referenced application, please amend the application as follows:

AMENDMENTS TO THE CLAIMS

REMARKS